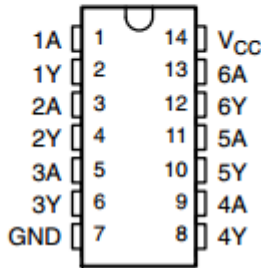


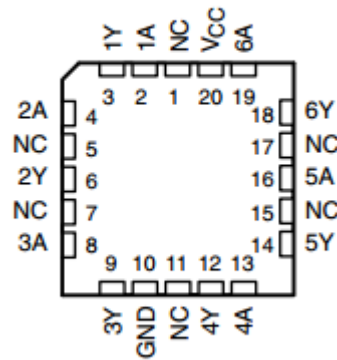
SN54AC04, SN74AC04 HEX INVERTERS

- 2-V to 6-V V_{CC} Operation
- Inputs Accept Voltages to 6 V
- Max t_{pd} of 7 ns at 5 V

SN54AC04 . . . J OR W PACKAGE
SN74AC04 . . . D, DB, N, NS, OR PW PACKAGE
(TOP VIEW)



SN54AC04 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

The 'AC04 devices contain six independent inverters. The devices perform the Boolean function $Y = \bar{A}$.

FUNCTION TABLE
(each inverter)

INPUT A	OUTPUT Y
H	L
L	H

logic diagram, each inverter (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC}	-0.5 V to 7 V
Input voltage range, V_I (see Note 1)	-0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Note 1)	-0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	± 20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	± 20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	± 50 mA
Continuous current through V_{CC} or GND	± 200 mA
Package thermal impedance, θ_{JA} (see Note 2):	
D package	86°C/W
DB package	96°C/W
N package	80°C/W
NS package	76°C/W
PW package	113°C/W
Storage temperature range, T_{stg}	-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

		SN54AC04		SN74AC04		UNIT
		MIN	MAX	MIN	MAX	
V_{CC}	Supply voltage	2	6	2	6	V
V_{IH}	High-level input voltage	$V_{CC} = 3\text{ V}$		2.1		V
		$V_{CC} = 4.5\text{ V}$		3.15		
		$V_{CC} = 5.5\text{ V}$		3.85		
V_{IL}	Low-level input voltage	$V_{CC} = 3\text{ V}$		0.9		V
		$V_{CC} = 4.5\text{ V}$		1.35		
		$V_{CC} = 5.5\text{ V}$		1.65		
V_I	Input voltage	0	V_{CC}	0	V_{CC}	V
V_O	Output voltage	0	V_{CC}	0	V_{CC}	V
I_{OH}	High-level output current	$V_{CC} = 3\text{ V}$		-12		mA
		$V_{CC} = 4.5\text{ V}$		-24		
		$V_{CC} = 5.5\text{ V}$		-24		
I_{OL}	Low-level output current	$V_{CC} = 3\text{ V}$		12		mA
		$V_{CC} = 4.5\text{ V}$		24		
		$V_{CC} = 5.5\text{ V}$		24		
$\Delta V/\Delta t$	Input transition rise or fall rate	8		8		ns/V
T_A	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V_{CC}	$T_A = 25^\circ\text{C}$			SN54AC04		SN74AC04		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V_{OH}	$I_{OH} = -50\ \mu\text{A}$	3 V	2.9	2.99		2.9		2.9	V	
		4.5 V	4.4	4.49		4.4		4.4		
		5.5 V	5.4	5.49		5.4		5.4		
	$I_{OH} = -12\text{ mA}$	3 V	2.56			2.4		2.46		
		4.5 V	3.86			3.7		3.76		
	$I_{OH} = -24\text{ mA}$	5.5 V	4.86			4.7		4.76		
		$I_{OH} = -50\text{ mA}^\dagger$	5.5 V			3.85				
$I_{OH} = -75\text{ mA}^\dagger$	5.5 V						3.85			
V_{OL}	$I_{OL} = 50\ \mu\text{A}$	3 V		0.002	0.1		0.1	0.1	V	
		4.5 V		0.001	0.1		0.1	0.1		
		5.5 V		0.001	0.1		0.1	0.1		
	$I_{OL} = 12\text{ mA}$	3 V			0.36		0.5	0.44		
		4.5 V			0.36		0.5	0.44		
	$I_{OL} = 24\text{ mA}$	5.5 V			0.36		0.5	0.44		
		$I_{OL} = 50\text{ mA}^\dagger$	5.5 V				1.65			
$I_{OL} = 75\text{ mA}^\dagger$	5.5 V						1.65			
I_I	$V_I = V_{CC}$ or GND	5.5 V			± 0.1		± 1	± 1	μA	
I_{CC}	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			2		40	20	μA	
C_i	$V_I = V_{CC}$ or GND				2.8				pF	

† Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

switching characteristics over recommended operating free-air temperature range, $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$T_A = 25^\circ\text{C}$			SN54AC04		SN74AC04		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	1.5	4.5	9	1	11	1	10	ns
t_{PHL}			1.5	4.5	8.5	1	10	1	9.5	

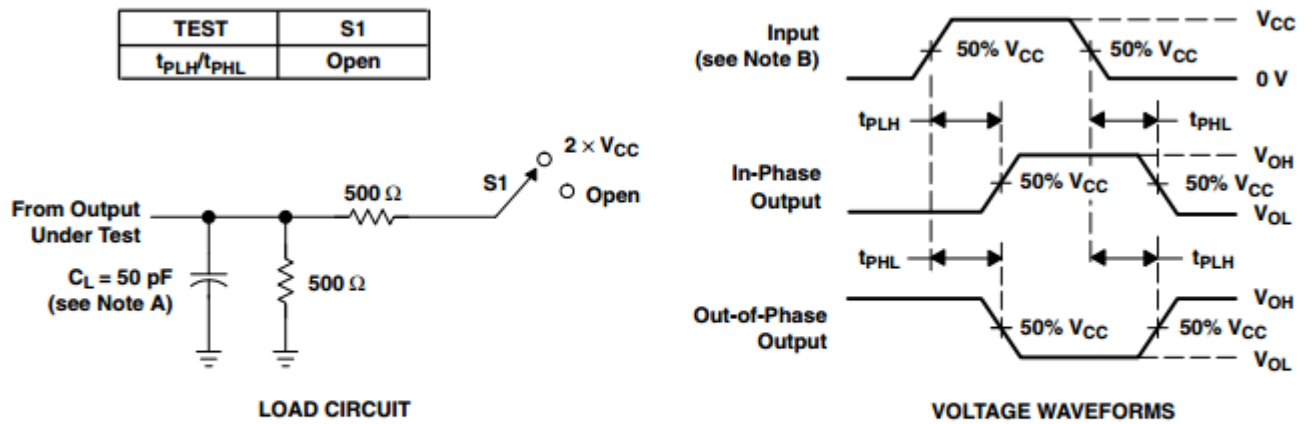
switching characteristics over recommended operating free-air temperature range, $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$T_A = 25^\circ\text{C}$			SN54AC04		SN74AC04		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	A	Y	1.5	4	7	1	8.5	1	7.5	ns
t_{PHL}			1.5	3.5	6.5	1	7.5	1	7	

operating characteristics, $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C_{pd} Power dissipation capacitance	$C_L = 50\text{ pF}$, $f = 1\text{ MHz}$	45	pF

PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and jig capacitance.
 B. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 2.5\text{ ns}$, $t_f \leq 2.5\text{ ns}$.
 C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms